## **Power MOSFET** -3.05 Amps, -30 Volts Dual P-Channel SO-8

### Features

- High Efficiency Components in a Dual SO-8 Package
- High Density Power MOSFET with Low R<sub>DS(on)</sub>
- Miniature SO-8 Surface Mount Package Saves Board Space
- Diode Exhibits High Speed with Soft Recovery
- I<sub>DSS</sub> Specified at Elevated Temperature
- Avalanche Energy Specified
- Mounting Information for the SO-8 Package is Provided

### Applications

- DC–DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery–Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular & Cordless Telephones

#### **MOSFET MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit				
Drain-to-Source Voltage	V <sub>DSS</sub>	-30	V				
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±20	V				
Thermal Resistance –							
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	171	°C/W				
Total Power Dissipation @ T <sub>A</sub> = 25°C	PD	0.73	W				
Continuous Drain Current @ 25°C	I <sub>D</sub>	-2.34	Α				
Continuous Drain Current @ 70°C	I <sub>D</sub>	-1.87	Α				
Pulsed Drain Current (Note 4)	I <sub>DM</sub>	-8.0	Α				
Thermal Resistance –							
Junction-to-Ambient (Note 2)	$R_{\thetaJA}$	100	°C/W				
Total Power Dissipation @ T <sub>A</sub> = 25°C	PD	1.25	W				
Continuous Drain Current @ 25°C	I <sub>D</sub>	-3.05	Α				
Continuous Drain Current @ 70°C	I <sub>D</sub>	-2.44	Α				
Pulsed Drain Current (Note 4)	I <sub>DM</sub>	-12	Α				
Thermal Resistance –							
Junction-to-Ambient (Note 3)	$R_{\theta JA}$	62.5	°C/W				
Total Power Dissipation @ T <sub>A</sub> = 25°C	PD	2.0	W				
Continuous Drain Current @ 25°C	I <sub>D</sub>	-3.86	Α				
Continuous Drain Current @ 70°C	I <sub>D</sub>	-3.1	Α				
Pulsed Drain Current (Note 4)	I <sub>DM</sub>	–15	A				
Operating and Storage	T <sub>J</sub> , T <sub>stg</sub>	-55 to	°C				
Temperature Range	Ū	+150					
Single Pulse Drain-to-Source Avalanche	E <sub>AS</sub>	140	mJ				
Energy – Starting $T_J = 25^{\circ}C$							
$(V_{DD} = -30 \text{ Vdc}, V_{GS} = -4.5 \text{ Vdc}, \text{ Peak}$							
$I_L$ = -7.5 Apk, L = 5 mH, R <sub>G</sub> = 25 $\Omega$ )							
Maximum Lead Temperature for Soldering	ΤL	260	°C				
Purposes, 1/8" from case for 10 seconds							

1. Minimum FR-4 or G-10 PCB, t = Steady State.

 Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t = steady state.

3. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t  $\leq$  10 seconds.

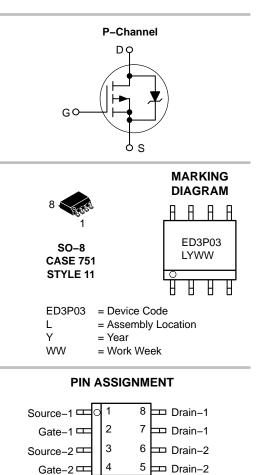
4. Pulse Test: Pulse Width =  $300 \ \mu$ s, Duty Cycle = 2%.



### ON Semiconductor®

### http://onsemi.com

V <sub>DSS</sub>	DSS R <sub>DS(ON)</sub> TYP	
–30 V	85 mΩ @ –10 V	–3.05 A



#### ORDERING INFORMATION

Top View

Device	Package	Shipping <sup>†</sup>
NTMD3P03R2	SO-8	2500/Tape & Reel

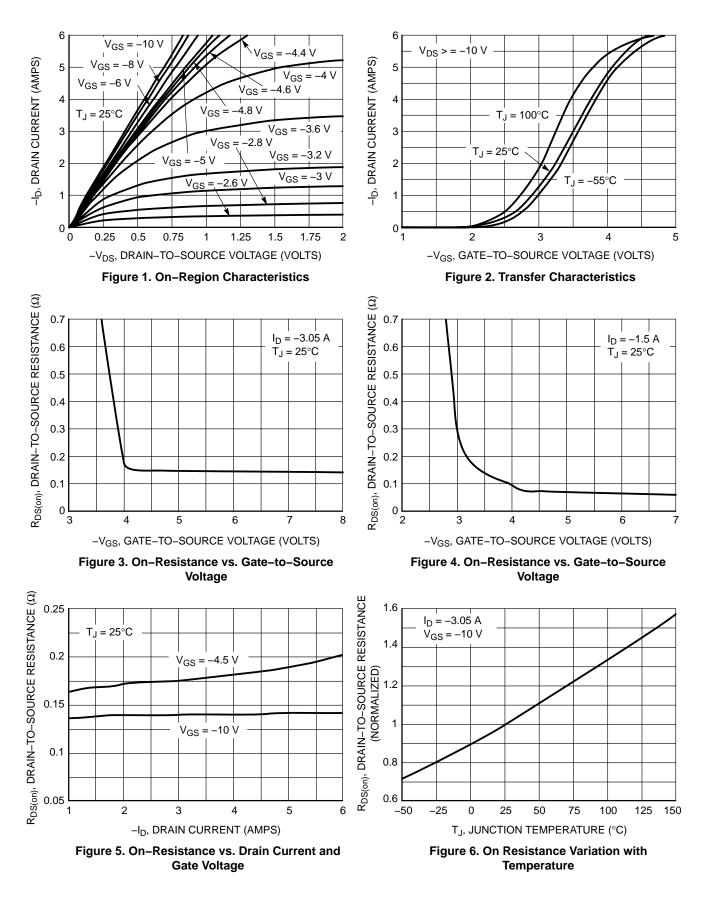
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

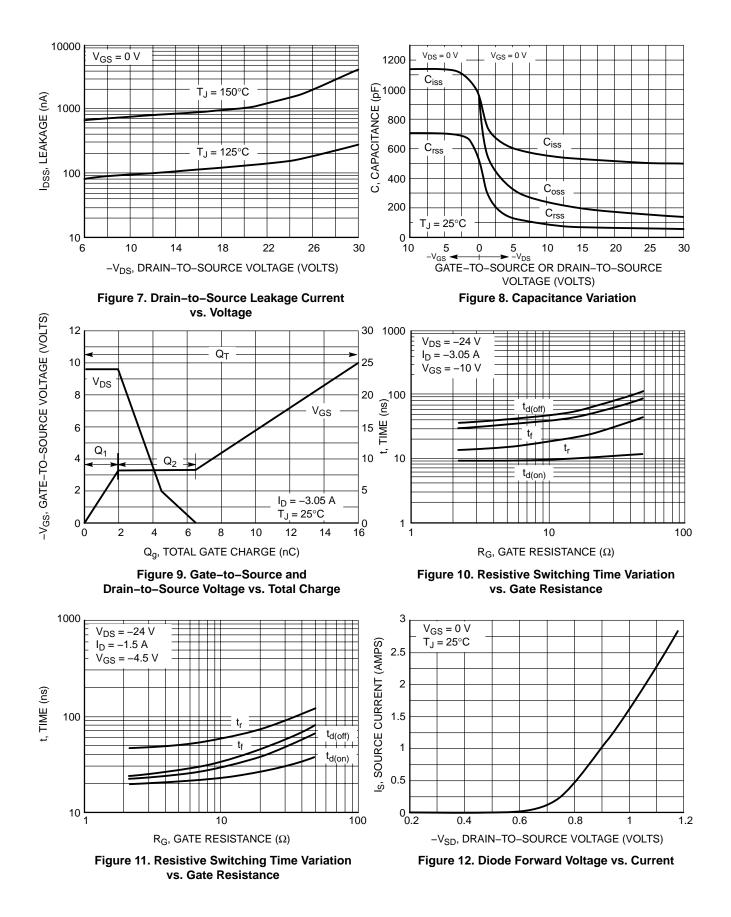
### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted) (Note 5)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS		· · · ·		1	r	
Drain-to-Source Breakdown Voltage ( $V_{GS} = 0 Vdc, I_D = -250 \mu Adc$ ) Temperature Coefficient (Positive)			-30 -	_ _30	-	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C})$ $(V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$ $(V_{DS} = -30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C})$			- - -		-1.0 -20 -2.0	μAdc
Gate-Body Leakage Current (V <sub>GS</sub> = -20 Vdc, V <sub>DS</sub> = 0 Vdc)			-	_	-100	nAdc
Gate-Body Leakage Current (V <sub>GS</sub> = +20 Vdc, V <sub>DS</sub> = 0 Vdc)			_	_	100	nAdc
ON CHARACTERISTICS		ļ		<u> </u>	<u> </u>	
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = -250 \ \mu Adc)$ Temperature Coefficient (Negative)			-1.0 _	-1.7 3.6	-2.5 -	Vdc
Static Drain-to-Source On-State Resistance $(V_{GS} = -10 \text{ Vdc}, I_D = -3.05 \text{ Adc})$ $(V_{GS} = -4.5 \text{ Vdc}, I_D = -1.5 \text{ Adc})$			- -	0.063 0.090	0.085 0.125	Ω
Forward Transconductance ( $V_{DS} = -15$ Vdc, $I_D = -3.05$ Adc)			_	5.0	_	Mhos
OYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>	_	520	750	pF
Output Capacitance	$(V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	_	170	325	
Reverse Transfer Capacitance	1.0 Wit (2)	C <sub>rss</sub>	_	70	135	
	Notes 6 and 7)					
Turn-On Delay Time		t <sub>d(on)</sub>	_	12	22	ns
Rise Time	$(V_{DD} = -24 \text{ Vdc}, I_D = -3.05 \text{ Adc},$	t <sub>r</sub>	_	16	30	
Turn–Off Delay Time	V <sub>GS</sub> = -10 Vdc, R <sub>G</sub> = 6.0 Ω)	t <sub>d(off)</sub>	_	45	80	
Fall Time		t <sub>f</sub>	-	45	80	
Turn-On Delay Time		t <sub>d(on)</sub>	_	16	-	ns
Rise Time	$(V_{DD} = -24 \text{ Vdc}, I_D = -1.5 \text{ Adc},$	t <sub>r</sub>	_	42	-	-
Turn-Off Delay Time	V <sub>GS</sub> = -4.5 Vdc, R <sub>G</sub> = 6.0 Ω)	t <sub>d(off)</sub>	-	32	-	
Fall Time		t <sub>f</sub>	_	35	-	
Total Gate Charge		Q <sub>tot</sub>	_	16	25	nC
Gate-Source Charge	(V <sub>DS</sub> = −24 Vdc, V <sub>GS</sub> = −10 Vdc,	Q <sub>gs</sub>	_	2.0	_	1
Gate–Drain Charge	$I_{\rm D} = -3.05 \; {\rm Adc})$	Q <sub>gd</sub>	_	4.5	_	
BODY-DRAIN DIODE RATINGS (No	te 6)				1	1
Diode Forward On–Voltage $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$		V <sub>SD</sub>	-	-0.96 -0.78	-1.25 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	_	34	-	ns
	(I <sub>S</sub> = -3.05 Adc, V <sub>GS</sub> = 0 Vdc, dI <sub>S</sub> /dt = 100 A/μs)	t <sub>a</sub>	-	18	-	_
		t <sub>b</sub>	_	16	-	
Reverse Recovery Stored Charge			_	0.03	_	μC

5. Handling precautions to protect against electrostatic discharge is mandatory. 6. Indicates Pulse Test: Pulse Width =  $300 \ \mu s \ max$ , Duty Cycle = 2%. 7. Switching characteristics are independent of operating junction temperature.

### **TYPICAL ELECTRICAL CHARACTERISTICS**





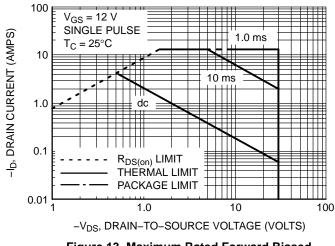


Figure 13. Maximum Rated Forward Biased Safe Operating Area

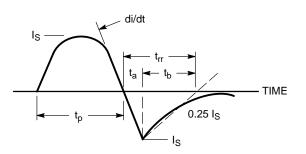


Figure 14. Diode Reverse Recovery Waveform

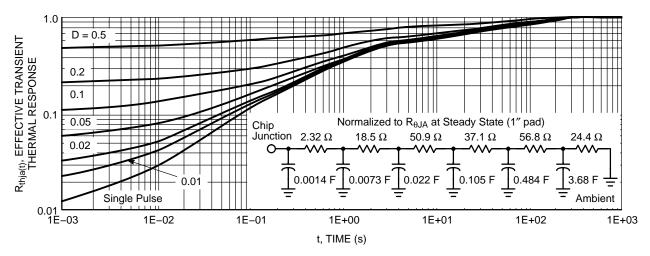
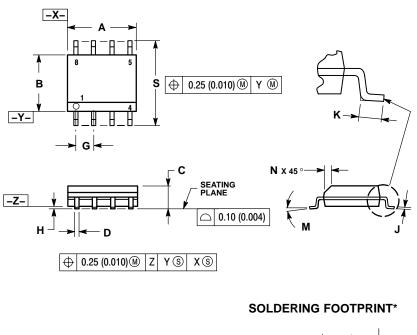


Figure 15. FET Thermal Response

#### PACKAGE DIMENSIONS

SO-8 CASE 751-07 **ISSUE AB** 



NOTES:

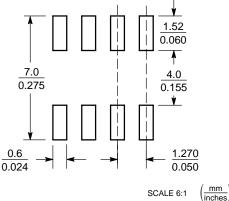
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
  MAXIMUM MOLD PROTRUSION 0.15 (0.006)

- PER SIDE.
- 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION. 751–01 THRU 751–06 ARE OBSOLETE. NEW 6 STANDARD IS 751-07.

	MILLIN	IETERS	INC	HES		
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	7 BSC	0.050 BSC			
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
Κ	0.40	1.27	0.016	0.050		
Μ	0 °	8 °	0 °	8 °		
Ν	0.25	0.50	0.010	0.020		
S	5 80	6 20	0 228	0 244		

STYLE 11 SOURCE 1 PIN 1. 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 DRAIN 2

- 6. DRAIN 1 7.
- DRAIN <sup>1</sup> 8.



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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